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Details

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Product Status	Active
Core Processor	dsPIC
Core Size	16-Bit
Speed	20 MIPS
Connectivity	I ² C, SPI, UART/USART
Peripherals	Brown-out Detect/Reset, POR, PWM, WDT
Number of I/O	20
Program Memory Size	24KB (8K x 24)
Program Memory Type	FLASH
EEPROM Size	1K x 8
RAM Size	2K x 8
Voltage - Supply (Vcc/Vdd)	2.5V ~ 5.5V
Data Converters	A/D 10x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	44-VQFN Exposed Pad
Supplier Device Package	44-QFN (8x8)
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/dspic30f3013t-20i-ml

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

Pin Diagrams



NOTES:

2.4.1 MULTIPLIER

The 17 x 17-bit multiplier is capable of signed or unsigned operation and can multiplex its output using a scaler to support either 1.31 fractional (Q31) or 32-bit integer results. Unsigned operands are zero-extended into the 17th bit of the multiplier input value. Signed operands are sign-extended into the 17th bit of the multiplier input value. The output of the 17 x 17-bit multiplier/scaler is a 33-bit value which is sign-extended to 40 bits. Integer data is inherently represented as a signed two's complement value, where the MSB is defined as a sign bit. Generally speaking, the range of an N-bit two's complement integer is -2^{N-1} to $2^{N-1} - 1$. For a 16-bit integer, the data range is -32768 (0x8000) to 32767 (0x7FFF) including '0'. For a 32-bit integer, the data range is -2,147,483,648 (0x8000 0000) to 2,147,483,645 (0x7FFF FFFF).

When the multiplier is configured for fractional multiplication, the data is represented as a two's complement fraction, where the MSB is defined as a sign bit and the radix point is implied to lie just after the sign bit (QX format). The range of an N-bit two's complement fraction with this implied radix point is -1.0 to $(1 - 2^{1-N})$. For a 16-bit fraction, the Q15 data range is -1.0 (0x8000) to 0.999969482 (0x7FFF) including '0' and has a precision of 3.01518×10^{-5} . In Fractional mode, the 16x16 multiply operation generates a 1.31 product, which has a precision of 4.65661×10^{-10} .

The same multiplier is used to support the MCU multiply instructions, which include integer 16-bit signed, unsigned and mixed sign multiplies.

The MUL instruction can be directed to use byte or word-sized operands. Byte operands direct a 16-bit result. Word operands direct a 32-bit result to the specified register(s) in the W array.

2.4.2 DATA ACCUMULATORS AND ADDER/SUBTRACTER

The data accumulator consists of a 40-bit adder/subtracter with automatic sign extension logic. It can select one of two accumulators (A or B) as its pre-accumulation source and post-accumulation destination. For the ADD and LAC instructions, the data to be accumulated or loaded can be optionally scaled through the barrel shifter prior to accumulation.

2.4.2.1 Adder/Subtracter, Overflow and Saturation

The adder/subtracter is a 40-bit adder with an optional zero input into one side and either true or complement data into the other input. In the case of addition, the carry/borrow input is active high and the other input is true data (not complemented), whereas in the case of subtraction, the carry/borrow input is active low and the other input is complemented. The adder/subtracter generates overflow status bits SA/SB and OA/OB, which are latched and reflected in the STATUS register:

- Overflow from bit 39: This is a catastrophic overflow in which the sign of the accumulator is destroyed.
- Overflow into guard bits 32 through 39: This is a recoverable overflow. This bit is set whenever all the guard bits are not identical to each other.

The adder has an additional saturation block which controls accumulator data saturation if selected. It uses the result of the adder, the overflow Status bits described above, and the mode control bits SATA/B (CORCON<7:6>) and ACCSAT (CORCON<4>) to determine when and to what value to saturate.

Six STATUS register bits have been provided to support saturation and overflow. They are:

- · OA: ACCA overflowed into guard bits
- · OB: ACCB overflowed into guard bits
- SA: ACCA saturated (bit 31 overflow and saturation) or

ACCA overflowed into guard bits and saturated (bit 39 overflow and saturation)

SB: ACCB saturated (bit 31 overflow and saturation)

ACCB overflowed into guard bits and saturated (bit 39 overflow and saturation)

OAB: Logical OR of OA and OB

or

• SAB: Logical OR of SA and SB

The OA and OB bits are modified each time data passes through the adder/subtracter. When set, they indicate that the most recent operation has overflowed into the accumulator guard bits (bits 32 through 39). The OA and OB bits can also optionally generate an arithmetic warning trap when set and the corresponding overflow trap flag enable bit (OVATE, OVBTE) in the INTCON1 register (refer to **Section 8.0 "Interrupts"**) is set. This allows the user to take immediate action, for example, to correct system gain.

3.2 Data Address Space

The core has two data spaces. The data spaces can be considered either separate (for some DSP instructions), or as one unified linear address range (for MCU instructions). The data spaces are accessed using two Address Generation Units (AGUs) and separate data paths.

3.2.1 DATA SPACE MEMORY MAP

The data space memory is split into two blocks, X and Y data space. A key element of this architecture is that Y space is a subset of X space, and is fully contained within X space. In order to provide an apparent Linear Addressing space, X and Y spaces have contiguous addresses.

When executing any instruction other than one of the MAC class of instructions, the X block consists of the 64 Kbyte data address space (including all Y addresses). When executing one of the MAC class of instructions, the X block consists of the 64 Kbyte data address space, excluding the Y address block (for data reads only). In other words, all other instructions regard the entire data memory as one composite address space. The MAC class instructions extract the Y address space from data space and address it using EAs sourced from W10 and W11. The remaining X data space is addressed using W8 and W9. Both address spaces are concurrently accessed only with the MAC class instructions.

The data space memory map for the dsPIC30F2011 and dsPIC30F2012 is shown in Figure 3-6. The data space memory map for the dsPIC30F3012 and dsPIC30F3013 is shown in Figure 3-7.



FIGURE 3-6: dsPIC30F2011/2012 DATA SPACE MEMORY MAP



6.3 Writing to the Data EEPROM

To write an EEPROM data location, the following sequence must be followed:

- 1. Erase data EEPROM word.
 - a) Select word, data EEPROM erase, and set WREN bit in NVMCON register.
 - b) Write address of word to be erased into NVMADR.
 - c) Enable NVM interrupt (optional).
 - d) Write 0x55 to NVMKEY.
 - e) Write 0xAA to NVMKEY.
 - f) Set the WR bit. This begins erase cycle.
 - g) Either poll NVMIF bit or wait for NVMIF interrupt.
 - h) The WR bit is cleared when the erase cycle ends.
- 2. Write data word into data EEPROM write latches.
- 3. Program 1 data word into data EEPROM.
 - a) Select word, data EEPROM program, and set WREN bit in NVMCON register.
 - b) Enable NVM write done interrupt (optional).
 - c) Write 0x55 to NVMKEY.
 - d) Write 0xAA to NVMKEY.
 - e) Set the WR bit. This begins program cycle.
 - f) Either poll NVMIF bit or wait for NVM interrupt.
 - g) The WR bit is cleared when the write cycle ends.

The write does not initiate if the above sequence is not exactly followed (write 0x55 to NVMKEY, write 0xAA to NVMCON, then set WR bit) for each word. It is strongly recommended that interrupts be disabled during this code segment.

Additionally, the WREN bit in NVMCON must be set to enable writes. This mechanism prevents accidental writes to data EEPROM due to unexpected code execution. The WREN bit should be kept clear at all times except when updating the EEPROM. The WREN bit is not cleared by hardware.

After a write sequence has been initiated, clearing the WREN bit does not affect the current write cycle. The WR bit is inhibited from being set unless the WREN bit is set. The WREN bit must be set on a previous instruction. Both WR and WREN cannot be set with the same instruction.

At the completion of the write cycle, the WR bit is cleared in hardware and the Nonvolatile Memory Write Complete Interrupt Flag bit (NVMIF) is set. The user may either enable this interrupt or poll this bit. NVMIF must be cleared by software.

6.3.1 WRITING A WORD OF DATA EEPROM

Once the user has erased the word to be programmed, then a table write instruction is used to write one write latch, as shown in Example 6-4.

6.3.2 WRITING A BLOCK OF DATA EEPROM

To write a block of data EEPROM, write to all sixteen latches first, then set the NVMCON register and program the block.

EXAMPLE 6-4: DATA EEPROM WORD WRITE

;	Point to data	a memory	
	MOV	<pre>#LOW_ADDR_WORD,W0</pre>	; Init pointer
	MOV	#HIGH_ADDR_WORD,W1	
	MOV	W1,TBLPAG	
	MOV	#LOW(WORD),W2	; Get data
	TBLWTL	W2,[W0]	; Write data
;	The NVMADR ca	aptures last table access address	
;	Select data	EEPROM for 1 word op	
	MOV	#0x4004,W0	
	MOV	W0,NVMCON	
;	Operate key	to allow write operation	
	DISI	#5	; Block all interrupts with priority <7 for
			; next 5 instructions
	MOV	#0x55,W0	
	MOV	W0 _, NVMKEY	; Write the 0x55 key
	MOV	#0xAA,W1	
	MOV	W1,NVMKEY	; Write the OxAA key
	BSET	NVMCON , #WR	; Initiate program sequence
	NOP		
	NOP		
;	Write cycle y	will complete in 2mS. CPU is not s	talled for the Data Write Cycle
;	User can pol	l WR bit, use NVMIF or Timer IRQ t	o determine write complete

13.0 SPI[™] MODULE

Note: This data sheet summarizes features of this group of dsPIC30F devices and is not intended to be a complete reference source. For more information on the CPU, peripherals, register descriptions and general device functionality, refer to the "dsPIC30F Family Reference Manual" (DS70046).

The Serial Peripheral Interface (SPI[™]) module is a synchronous serial interface. It is useful for communicating with other peripheral devices, such as EEPROMs, shift registers, display drivers and A/D converters, or other microcontrollers. It is compatible with Motorola's SPI and SIOP interfaces. The dsPIC30F2011/2012/3012/3013 devices feature one SPI module, SPI1.

13.1 Operating Function Description

Figure 13-1 is a simplified block diagram of the SPI module, which consists of a 16-bit shift register, SPI1SR, used for shifting data in and out, and a buffer register, SPI1BUF. Control register SPI1CON (not shown) configures the module. Additionally, status register SPI1STAT (not shown) indicates various status conditions.

Note:	See	"dsP	PIC30F		Famil	y R	Reference	
	Manual"		(DS7004		l6) for		detailed	
	inform	nation	on t	the	contr	ol an	d sta	tus
	regist	ers.						

Four I/O pins comprise the serial interface:

- SDI1 (serial data input)
- SDO1 (serial data output)
- SCK1 (shift clock input or output)
- SS1 (active-low slave select).

In Master mode operation, SCK1 is a clock output. In Slave mode, it is a clock input.

A series of eight (8) or sixteen (16) clock pulses shift out bits from the SPI1SR to SDO1 pin and simultaneously shift in data from SDI1 pin. An interrupt is generated when the transfer is complete and the interrupt flag bit (SPI1IF) is set. This interrupt can be disabled through the interrupt enable bit, SPI1IE.

The receive operation is double-buffered. When a complete byte is received, it is transferred from SPI1SR to SPI1BUF.

If the receive buffer is full when new data is being transferred from SPI1SR to SPI1BUF, the module will set the SPIROV bit indicating an overflow condition. The transfer of the data from SPI1SR to SPI1BUF is not completed and the new data is lost. The module will not respond to SCL transitions while SPIROV is '1', effectively disabling the module until SPI1BUF is read by user software.

Transmit writes are also double-buffered. The user writes to SPI1BUF. When the master or slave transfer is completed, the contents of the shift register (SPI1SR) are moved to the receive buffer. If any transmit data has been written to the buffer register, the contents of the transmit buffer are moved to SPI1SR. The received data is thus placed in SPI1BUF and the transmit data in SPI1SR is ready for the next transfer.

Note: Both the transmit buffer (SPI1TXB) and the receive buffer (SPI1RXB) are mapped to the same register address, SPI1BUF.

TABLE 13-1: SPI1 REGISTER MAP

SFR Name	Addr.	Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Reset State
SPI1STAT	0220	SPIEN	—	SPISIDL	—	—	—	_	_	—	SPIROV	—	—	—	—	SPITBF	SPIRBF	0000 0000 0000 0000
SPI1CON	0222	_	FRMEN	SPIFSD		DISSDO	MODE16	SMP	CKE	SSEN	CKP	MSTEN	SPRE2	SPRE1	SPRE0	PPRE1	PPRE0	0000 0000 0000 0000
SPI1BUF	0224							Tra	ansmit an	d Receive	Buffer							0000 0000 0000 0000

Legend: — = unimplemented bit, read as '0'

Note: Refer to the "dsPIC30F Family Reference Manual" (DS70046) for descriptions of register bit fields.

16.7 ADC Speeds

The dsPIC30F 12-bit ADC specifications permit a maximum of 200 ksps sampling rate. Table 16-1 summarizes the conversion speeds for the dsPIC30F 12-bit ADC and the required operating conditions.

Figure 16-2 depicts the recommended circuit for the conversion rates above 200 ksps. The dsPIC30F2011 is shown as an example.

	dsPIC30F 12-bit ADC Conversion Rates												
Speed	TAD Minimum	Sampling Time Min	R _s Max	Vdd	Temperature	Channel Configuration							
Up to 200 ksps ⁽¹⁾	334 ns	1 Tad	2.5 kΩ	4.5V to 5.5V	-40°C to +85°C	ANX CHX ANX ADC							
Up to 100 ksps	668 ns	1 Tad	2.5 kΩ	3.0V to 5.5V	-40°C to +125°C	ANX ANX OF VREF-							

Note 1: External VREF- and VREF+ pins must be used for correct operation. See Figure 16-2 for recommended circuit.

FIGURE 16-2: ADC VOLTAGE REFERENCE SCHEMATIC



17.2 Oscillator Configurations

17.2.1 INITIAL CLOCK SOURCE SELECTION

While coming out of Power-on Reset or Brown-out Reset, the device selects its clock source based on:

- a) FOS<2:0> Configuration bits that select one of four oscillator groups,
- b) and FPR<4:0> Configuration bits that select one of 15 oscillator choices within the primary group.

The selection is as shown in Table 17-2.

17.2.2 OSCILLATOR START-UP TIMER (OST)

In order to ensure that a crystal oscillator (or ceramic resonator) has started and stabilized, an Oscillator Start-up Timer is included. It is a simple 10-bit counter that counts 1024 Tosc cycles before releasing the oscillator clock to the rest of the system. The time-out period is designated as Tost.

The TOST time is involved every time the oscillator has to restart (i.e., on POR, BOR and wake-up from Sleep). The Oscillator Start-up Timer is applied to the LP oscillator, XT, XTL and HS modes (upon wake-up from Sleep, POR and BOR) for the primary oscillator.

Oscillator Mode	Oscillator Source	F	OS<2:0)>	FPR<4:0>					OSC2 Function
ECIO w/PLL 4x	PLL	1	1	1	0	1	1	0	1	I/O
ECIO w/PLL 8x	PLL	1	1	1	0	1	1	1	0	I/O
ECIO w/PLL 16x	PLL	1	1	1	0	1	1	1	1	I/O
FRC w/PLL 4X	PLL	1	1	1	0	0	0	0	1	I/O
FRC w/PLL 8x	PLL	1	1	1	0	1	0	1	0	I/O
FRC w/PLL 16x	PLL	1	1	1	0	0	0	1	1	I/O
XT w/PLL 4x	PLL	1	1	1	0	0	1	0	1	OSC2
XT w/PLL 8x	PLL	1	1	1	0	0	1	1	0	OSC2
XT w/PLL 16x	PLL	1	1	1	0	0	1	1	1	OSC2
HS2 w/PLL 4x	PLL	1	1	1	1	0	0	0	1	OSC2
HS2 w/PLL 8x	PLL	1	1	1	1	0	0	1	0	OSC2
HS2 w/ PLL 16x	PLL	1	1	1	1	0	0	1	1	OSC2
HS3 w/PLL 4x	PLL	1	1	1	1	0	1	0	1	OSC2
HS3 w/PLL 8x	PLL	1	1	1	1	0	1	1	0	OSC2
HS3 w/PLL 16x	PLL	1	1	1	1	0	1	1	1	OSC2
ECIO	External	0	1	1	0	1	1	0	0	I/O
ХТ	External	0	1	1	0	0	1	0	0	OSC2
HS	External	0	1	1	0	0	0	1	0	OSC2
EC	External	0	1	1	0	1	0	1	1	CLKO
ERC	External	0	1	1	0	1	0	0	1	CLKO
ERCIO	External	0	1	1	0	1	0	0	0	I/O
XTL	External	0	1	1	0	0	0	0	0	OSC2
LP	Secondary	0	0	0	Х	Х	Х	Х	Х	(Note 1, 2)
FRC	Internal FRC	0	0	1	Х	Х	Х	Х	Х	(Note 1, 2)
LPRC	Internal LPRC	0	1	0	Х	Х	Х	Х	Х	(Note 1, 2)

TABLE 17-2: CONFIGURATION BIT VALUES FOR CLOCK SELECTION

Note 1: The OSC2 pin is either usable as a general purpose I/O pin or is completely unusable, depending on the Primary Oscillator mode selection (FPR<4:0>).

2: OSC1 pin cannot be used as an I/O pin even if the secondary oscillator or an internal clock source is selected at all times.

17.2.7 FAIL-SAFE CLOCK MONITOR

The Fail-Safe Clock Monitor (FSCM) allows the device to continue to operate even in the event of an oscillator failure. The FSCM function is enabled by appropriately programming the FCKSM Configuration bits (clock switch and monitor selection bits) in the FOSC Device Configuration register. If the FSCM function is enabled, the LPRC internal oscillator will run at all times (except during Sleep mode) and will not be subject to control by the SWDTEN bit.

In the event of an oscillator failure, the FSCM will generate a clock failure trap event and will switch the system clock over to the FRC oscillator. The user will then have the option to either attempt to restart the oscillator or execute a controlled shutdown. The user may decide to treat the trap as a warm Reset by simply loading the Reset address into the oscillator fail trap vector. In this event, the CF (Clock Fail) bit (OSCCON<3>) is also set whenever a clock failure is recognized.

In the event of a clock failure, the WDT is unaffected and continues to run on the LPRC clock.

If the oscillator has a very slow start-up time coming out of POR, BOR or Sleep, it is possible that the PWRT timer will expire before the oscillator has started. In such cases, the FSCM will be activated and the FSCM will initiate a clock failure trap, and the COSC<2:0> bits are loaded with FRC oscillator selection. This will effectively shut-off the original oscillator that was trying to start.

The user may detect this situation and restart the oscillator in the clock fail trap ISR.

Upon a clock failure detection, the FSCM module will initiate a clock switch to the FRC oscillator as follows:

- 1. The COSC bits (OSCCON<14:12>) are loaded with the FRC oscillator selection value.
- 2. CF bit is set (OSCCON<3>).
- 3. OSWEN control bit (OSCCON<0>) is cleared.

For the purpose of clock switching, the clock sources are sectioned into four groups:

- Primary (with or without PLL)
- Secondary
- Internal FRC
- Internal LPRC

The user can switch between these functional groups but cannot switch between options within a group. If the primary group is selected, then the choice within the group is always determined by the FPR<4:0> Configuration bits. The OSCCON register holds the Control and Status bits related to clock switching.

- COSC<2:0>: Read-only bits always reflect the current oscillator group in effect.
- NOSC<2:0>: Control bits which are written to indicate the new oscillator group of choice.
 - On POR and BOR, COSC<2:0> and NOSC<2:0> are both loaded with the Configuration bit values FOS<2:0>.
- LOCK: The LOCK bit indicates a PLL lock.
- CF: Read-only bit indicating if a clock fail detect has occurred.
- OSWEN: Control bit changes from a '0' to a '1' when a clock transition sequence is initiated. Clearing the OSWEN control bit will abort a clock transition in progress (used for hang-up situations).

If Configuration bits FCKSM<1:0> = 1x, then the clock switching and Fail-Safe Clock monitoring functions are disabled. This is the default Configuration bit setting.

If clock switching is disabled, then the FOS<2:0> and FPR<4:0> bits directly control the oscillator selection and the COSC<2:0> bits do not control the clock selection. However, these bits will reflect the clock source selection.

Note: The application should not attempt to switch to a clock of frequency lower than 100 kHz when the Fail-Safe Clock Monitor is enabled. If such clock switching is performed, the device may generate an oscillator fail trap and switch to the Fast RC oscillator.

17.2.8 PROTECTION AGAINST ACCIDENTAL WRITES TO OSCCON

A write to the OSCCON register is intentionally made difficult because it controls clock switching and clock scaling.

To write to the OSCCON low byte, the following code sequence must be executed without any other instructions in between:

Byte Write 0x46 to OSCCON low Byte Write 0x57 to OSCCON low

Byte write is allowed for one instruction cycle. Write the desired value or use bit manipulation instruction.

To write to the OSCCON high byte, the following instructions must be executed without any other instructions in between:

Byte Write 0x78 to OSCCON high Byte Write 0x9A to OSCCON high

Byte write is allowed for one instruction cycle. Write the desired value or use bit manipulation instruction.

17.8 Peripheral Module Disable (PMD) Registers

The Peripheral Module Disable (PMD) registers provide a method to disable a peripheral module by stopping all clock sources supplied to that module. When a peripheral is disabled via the appropriate PMD control bit, the peripheral is in a minimum power consumption state. The Control and Status registers associated with the peripheral will also be disabled so writes to those registers will have no effect and read values will be invalid.

A peripheral module will only be enabled if both the associated bit in the PMD register is cleared and the peripheral is supported by the specific dsPIC DSC variant. If the peripheral is present in the device, it is enabled in the PMD register by default.

- **Note 1:** If a PMD bit is set, the corresponding module is disabled after a delay of 1 instruction cycle. Similarly, if a PMD bit is cleared, the corresponding module is enabled after a delay of 1 instruction cycle (assuming the module Control registers are already configured to enable module operation).
 - 2: In dsPIC30F2011, dsPIC30F3012 and dsPIC30F2012 devices, the U2MD bit is readable and writable and will be read as '1' when set.

17.9 In-Circuit Debugger

When MPLAB[®] ICD 2 is selected as a Debugger, the In-Circuit Debugging functionality is enabled. This function allows simple debugging functions when used with MPLAB IDE. When the device has this feature enabled, some of the resources are not available for general use. These resources include the first 80 bytes of Data RAM and two I/O pins.

One of four pairs of Debug I/O pins may be selected by the user using configuration options in MPLAB IDE. These pin pairs are named EMUD/EMUC, EMUD1/EMUC1, EMUD2/EMUC2 and EMUD3/EMUC3.

In each case, the selected EMUD pin is the Emulation/Debug Data line, and the EMUC pin is the Emulation/Debug Clock line. These pins will interface to the MPLAB ICD 2 module available from Microchip. The selected pair of Debug I/O pins is used by MPLAB ICD 2 to send commands and receive responses, as well as to send and receive data. To use the In-Circuit Debugger function of the device, the design must implement ICSP connections to MCLR, VDD, VSS, PGC, PGD and the selected EMUDx/EMUCx pin pair.

This gives rise to two possibilities:

- 1. If EMUD/EMUC is selected as the Debug I/O pin pair, then only a 5-pin interface is required, as the EMUD and EMUC pin functions are multiplexed with the PGD and PGC pin functions in all dsPIC30F devices.
- If EMUD1/EMUC1, EMUD2/EMUC2 or EMUD3/EMUC3 is selected as the Debug I/O pin pair, then a 7-pin interface is required, as the EMUDx/EMUCx pin functions (x = 1, 2 or 3) are not multiplexed with the PGD and PGC pin functions.

Field	Description
Wb	Base W register ∈ {W0W15}
Wd	Destination W register ∈ { Wd, [Wd], [Wd++], [Wd], [++Wd], [Wd] }
Wdo	Destination W register ∈ { Wnd, [Wnd], [Wnd++], [Wnd], [++Wnd], [Wnd], [Wnd+Wb] }
Wm,Wn	Dividend, Divisor working register pair (direct addressing)
Wm*Wm	Multiplicand and Multiplier working register pair for Square instructions ∈ {W4*W4,W5*W5,W6*W6,W7*W7}
Wm*Wn	Multiplicand and Multiplier working register pair for DSP instructions ∈ {W4*W5,W4*W6,W4*W7,W5*W6,W5*W7,W6*W7}
Wn	One of 16 working registers ∈ {W0W15}
Wnd	One of 16 destination working registers ∈ {W0W15}
Wns	One of 16 source working registers ∈ {W0W15}
WREG	W0 (working register used in file register instructions)
Ws	Source W register ∈ { Ws, [Ws], [Ws++], [Ws], [++Ws], [Ws] }
Wso	Source W register ∈ { Wns, [Wns], [Wns++], [Wns], [++Wns], [Wns], [Wns+Wb] }
Wx	X data space prefetch address register for DSP instructions ∈ {[W8]+=6, [W8]+=4, [W8]+=2, [W8], [W8]-=6, [W8]-=4, [W8]-=2, [W9]+=6, [W9]+=4, [W9]+=2, [W9], [W9]-=6, [W9]-=4, [W9]-=2, [W9+W12],none}
Wxd	X data space prefetch destination register for DSP instructions ∈ {W4W7}
Wy	Y data space prefetch address register for DSP instructions ∈ {[W10]+=6, [W10]+=4, [W10]+=2, [W10], [W10]-=6, [W10]-=4, [W10]-=2, [W11]+=6, [W11]+=4, [W11]+=2, [W11], [W11]-=6, [W11]-=4, [W11]-=2, [W11+W12], none}
Wyd	Y data space prefetch destination register for DSP instructions ∈ {W4W7}

TABLE 18-1: SYMBOLS USED IN OPCODE DESCRIPTIONS (CONTINUED)

TABLE 20-15: PLL CLOCK TIMING SPECIFICATIONS (VDD = 2.5 TO 5.5 V)

AC CHA	RACTERI	STICS	Standard Operating Conditions: 2.5V to 5.5V (unless otherwise stated) Operating temperature -40°C ≤TA ≤+85°C for Industrial -40°C ≤TA ≤+125°C for Extended						
Param No.	Symbol	Characterist	Min	Тур ⁽²⁾	Max	Units	Conditions		
OS50	Fplli	PLL Input Frequency	/ Range ⁽²⁾	4		10	MHz	EC with 4x PLL	
				4	—	10	MHz	EC with 8x PLL	
				4	—	7.5 ⁽⁴⁾	MHz	EC with 16x PLL	
				4	—	10	MHz	XT with 4x PLL	
				4	—	10	MHz	XT with 8x PLL	
				4	—	7.5 ⁽⁴⁾	MHz	XT with 16x PLL	
				5 ⁽³⁾	—	10	MHz	HS/2 with 4x PLL	
				5 ⁽³⁾	—	10	MHz	HS/2 with 8x PLL	
				5 ⁽³⁾	—	7.5 ⁽⁴⁾	MHz	HS/2 with 16x PLL	
				4	—	8.33 ⁽³⁾	MHz	HS/3 with 4x PLL	
				4	—	8.33 ⁽³⁾	MHz	HS/3 with 8x PLL	
				4	—	7.5 ⁽⁴⁾	MHz	HS/3 with 16x PLL	
OS51	Fsys	On-Chip PLL Output	(2)	16		120	MHz	EC, XT, HS/2, HS/3 modes with PLL	
OS52	TLOC	PLL Start-up Time (L	.ock Time)	_	20	50	μs		

Note 1: These parameters are characterized but not tested in manufacturing.

2: Data in "Typ" column is at 5V, 25°C unless otherwise stated. Parameters are for design guidance only and are not tested.

3: Limited by oscillator frequency range.

4: Limited by device operating frequency range.

TABLE 20-16: PLL JITTER

АС СНА	RACTERISTICS	Standard Operating Conditions: 2.5V to 5.5V(unless otherwise stated)Operating temperature $-40^{\circ}C \leq TA \leq +85^{\circ}C$ for Industrial $-40^{\circ}C \leq TA \leq +125^{\circ}C$ for Extended							
Param No.	Characteristic	Min	Typ ⁽¹⁾	Max	Units	Conditions			
OS61	x4 PLL	—	0.251	0.413	%	-40°C ≤TA ≤+85°C	VDD = 3.0 to 3.6V		
		_	0.251	0.413	%	-40°C ≤TA ≤+125°C	VDD = 3.0 to 3.6V		
		—	0.256	0.47	%	-40°C ≤TA ≤+85°C	VDD = 4.5 to 5.5V		
		_	0.256	0.47	%	-40°C ≤TA ≤+125°C	VDD = 4.5 to 5.5V		
	x8 PLL	_	0.355	0.584	%	-40°C ≤TA ≤+85°C	VDD = 3.0 to 3.6V		
		_	0.355	0.584	%	-40°C ≤TA ≤+125°C	VDD = 3.0 to 3.6V		
		_	0.362	0.664	%	-40°C ≤TA ≤+85°C	VDD = 4.5 to 5.5V		
		_	0.362	0.664	%	-40°C ≤TA ≤+125°C	VDD = 4.5 to 5.5V		
	x16 PLL	_	0.67	0.92	%	-40°C ≤TA ≤+85°C	VDD = 3.0 to 3.6V		
		_	0.632	0.956	%	-40°C ≤TA ≤+85°C	VDD = 4.5 to 5.5V		
		_	0.632	0.956	%	-40°C ≤TA ≤+125°C	VDD = 4.5 to 5.5V		

Note 1: These parameters are characterized but not tested in manufacturing.

Clock Oscillator Mode	Fosc (MHz) ⁽¹⁾	Τ C Υ (μ sec)⁽²⁾	MIPS ⁽³⁾ w/o PLL	MIPS ⁽³⁾ w PLL x4	MIPS ⁽³⁾ w PLL x8	MIPS ⁽³⁾ w PLL x16
EC	0.200	20.0	0.05	—		—
	4	1.0	1.0	4.0	8.0	16.0
	10	0.4	2.5	10.0	20.0	—
	25	0.16	6.25	—	—	—
XT	4	1.0	1.0	4.0	8.0	16.0
	10	0.4	2.5	10.0	20.0	

TABLE 20-17: INTERNAL CLOCK TIMING EXAMPLES

Note 1: Assumption: Oscillator Postscaler is divide by 1.

2: Instruction Execution Cycle Time: TCY = 1/MIPS.

3: Instruction Execution Frequency: MIPS = (Fosc * PLLx)/4 [since there are 4 Q clocks per instruction cycle].

TABLE 20-18: AC CHARACTERISTICS: INTERNAL FRC ACCURACY

AC CHA	RACTERISTICS	Standar (unless Operatir	Standard Operating Conditions: 2.5V to 5.5V (unless otherwise stated) Operating temperature -40°C ≤TA ≤+85°C for Industrial -40°C ≤TA ≤+125°C for Extended							
Param No.	Characteristic	Min	Тур	Max	Units	Conditions				
	Internal FRC Accuracy @	FRC Fr	eq. = 7.3	7 MHz ⁽¹⁾						
OS63	FRC	—	—	±2.00	%	-40°C ≤TA ≤+85°C	VDD = 3.0-5.5V			
		—	—	±5.00	%	-40°C ≤TA ≤+125°C	VDD = 3.0-5.5V			

Note 1: Frequency calibrated at 7.372 MHz ±2%, 25°C and 5V. TUN bits (OSCCON<3:0>) can be used to compensate for temperature drift.

TABLE 20-19: AC CHARACTERISTICS: INTERNAL LPRC ACCURACY

AC CHARACTERISTICS		Standard Operating Conditions: 2.5V to 5.5V (unless otherwise stated) Operating temperature -40°C ≤TA ≤+85°C for Industrial -40°C ≤TA ≤+125°C for Extended					
Param No.	Characteristic	Min	Min Typ Max Units Conditions				
	LPRC @ Freq. = 512 kHz ⁽¹⁾						
OS65A		-50	-	+50	%	$VDD = 5.0V, \pm 10\%$	
OS65B		-60	_	+60	%	VDD = 3.3V, ±10%	
OS65C		-70		+70	%	VDD = 2.5V	

Note 1: Change of LPRC frequency as VDD changes.



FIGURE 20-14: SPI MODULE SLAVE MODE (CKE = 0) TIMING CHARACTERISTICS

TABLE 20-31: SPI MODULE SLAVE MODE (CKE = 0) TIMING REQUIREMENTS

AC CHARACTERISTICS			Standard Operating Conditions: 2.5V to 5.5V (unless otherwise stated) Operating temperature -40°C ≤TA ≤+85°C for Industrial -40°C ≤TA ≤+125°C for Extended				
Param No.	Symbol	Characteristic ⁽¹⁾	Min	Тур ⁽²⁾	Мах	Units	Conditions
SP70	TscL	SCKx Input Low Time	30	—		ns	—
SP71	TscH	SCKx Input High Time	30	_		ns	
SP72	TscF	SCKx Input Fall Time ⁽³⁾		10	25	ns	—
SP73	TscR	SCKx Input Rise Time ⁽³⁾		10	25	ns	
SP30	TdoF	SDOx Data Output Fall Time ⁽³⁾		_		ns	See DO32
SP31	TdoR	SDOx Data Output Rise Time ⁽³⁾		_		ns	See DO31
SP35	TscH2doV, TscL2doV	SDOx Data Output Valid after SCKx Edge		—	30	ns	—
SP40	TdiV2scH, TdiV2scL	Setup Time of SDIx Data Input to SCKx Edge	20	—	—	ns	—
SP41	TscH2diL, TscL2diL	Hold Time of SDIx Data Input to SCKx Edge	20	—	_	ns	—
SP50	TssL2scH, TssL2scL	SSx↓to SCKx↑ or SCKx↓Input	120	—		ns	—
SP51	TssH2doZ	SSx↑ to SDOx Output high impedance ⁽³⁾	10	—	50	ns	—
SP52	TscH2ssH TscL2ssH	SSx after SCK Edge	1.5 Tcy +40	—	_	ns	—

Note 1: These parameters are characterized but not tested in manufacturing.

2: Data in "Typ" column is at 5V, 25°C unless otherwise stated. Parameters are for design guidance only and are not tested.

3: Assumes 50 pF load on all SPI pins.

NOTES:

18-Lead Plastic Small Outline (SO) – Wide, 7.50 mm Body [SOIC]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units	MILLIMETERS			
	Dimension Limits	MIN	NOM	MAX	
Number of Pins	N				
Pitch	e	1.27 BSC			
Overall Height	A		—	2.65	
Molded Package Thickness	A2	2.05	_	_	
Standoff §	A1	0.10	_	0.30	
Overall Width	E	10.30 BSC			
Molded Package Width	E1	7.50 BSC			
Overall Length	D	11.55 BSC			
Chamfer (optional)	h	0.25	_	0.75	
Foot Length	L	0.40	_	1.27	
Footprint	L1	1.40 REF			
Foot Angle	φ	0°	_	8°	
Lead Thickness	С	0.20	-	0.33	
Lead Width	b	0.31	_	0.51	
Mold Draft Angle Top	α	5°	_	15°	
Mold Draft Angle Bottom	β	5°	_	15°	

Notes:

1. Pin 1 visual index feature may vary, but must be located within the hatched area.

2. § Significant Characteristic.

3. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.15 mm per side.

- 4. Dimensioning and tolerancing per ASME Y14.5M.
 - BSC: Basic Dimension. Theoretically exact value shown without tolerances.

REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-051B

28-Lead Plastic Small Outline (SO) – Wide, 7.50 mm Body [SOIC]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging









	Units	MILLIMETERS			
	Dimension Limits		NOM	MAX	
Number of Pins	N	28			
Pitch	е	1.27 BSC			
Overall Height	А	-	-	2.65	
Molded Package Thickness	A2	2.05	-	-	
Standoff §	A1	0.10	-	0.30	
Overall Width	E	10.30 BSC			
Molded Package Width	E1	7.50 BSC			
Overall Length	D	17.90 BSC			
Chamfer (optional)	h	0.25	-	0.75	
Foot Length	L	0.40	-	1.27	
Footprint	L1	1.40 REF			
Foot Angle Top	ф	0°	_	8°	
Lead Thickness	С	0.18	-	0.33	
Lead Width	b	0.31	-	0.51	
Mold Draft Angle Top	α	5°	_	15°	
Mold Draft Angle Bottom	β	5°	_	15°	

Notes:

1. Pin 1 visual index feature may vary, but must be located within the hatched area.

2. § Significant Characteristic.

3. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.15 mm per side.

- 4. Dimensioning and tolerancing per ASME Y14.5M.
 - BSC: Basic Dimension. Theoretically exact value shown without tolerances.

REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-052B

NOTES: